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Intrinsic measurements of exciton transport in photovoltaic cells

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Organic photovoltaic cells are particularly sensitive to exciton harvesting and are thus, a useful platform for the characterization of exciton diffusion. While device photocurrent spectroscopy can be used to extract the exciton diffusion length, this method is frequently limited by unknown interfacial recombination losses. We resolve this limitation and demonstrate a general, device-based photocurrent-ratio measurement to extract the intrinsic diffusion length. Since interfacial losses are not active layer specific, a ratio of the donor- and acceptor-material internal quantum efficiencies cancels this quantity. We further show that this measurement permits extraction of additional device-relevant information regarding exciton relaxation and charge separation processes. The generality of this method is demonstrated by measuring exciton transport for both luminescent and dark materials, as well as for small molecule and polymer active materials and semiconductor quantum dots. Thus, we demonstrate a broadly applicable device-based methodology to probe the intrinsic active material exciton diffusion length.

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Excitons are Coulombically-bound electron-hole pairs that serve as energetic intermediates in semiconductors. In many emerging semiconductor materials, the exciton and its properties feature prominently in determining device applications due to large binding energies that stabilize the exciton against thermally-driven dissociation^{1–8}. Indeed, the high stability of the exciton has driven much research into the design of active materials and device architectures for organic light-emitting devices and organic photovoltaic cells (OPVs)^{9–15}. Recently, there has also been growing interest in manipulating exciton transport at semiconductor heterointerfaces for devices like excitonic transistors^{16–18}. For OPVs, in particular, excitons must migrate to a dissociating electron donor–acceptor (D–A) interface, making exciton transport a critical step towards efficient photoconversion^{19–24}. Consequently, substantial previous work has been directed at both the measurement and engineering of the exciton diffusion length (L_D). These efforts are essential as the scale of L_D dictates the optimal active layer thickness and domain size of D–A blends in planar (PHJ) and bulk heterojunction (BHJ) OPVs, respectively^{25–29}.

Probing exciton migration often relies on tracking the end-of-life products of excitons, including photons from exciton recombination and charge carriers from exciton dissociation^{30,31}. For luminescent materials, L_D can be determined from a steady-state or time-resolved photoluminescence (PL)-based measurement^{22,32,33}. Emitted photons reflect excitons that fail to reach the dissociating interface. While capable of yielding a materials-relevant value of L_D , this method is only sensitive to diffusive states that can decay radiatively and therefore cannot be applied to materials forming weakly emissive or dark excitons^{34–36}. Since many high-performing active materials are weakly luminescent or dark^{7,12,35,37,38}, it is essential to develop more general means to accurately probe exciton transport in working devices.

A more general approach to extract L_D is by fitting the measured photocurrent (i.e., external quantum efficiency) spectrum of a bilayer OPV^{39–41}. Device-based methods are attractive as they probe the L_D in a practical environment, as opposed to the often idealized structures utilized for PL measurements. This method is equally applicable to all excitons regardless of photoluminescence efficiency. Photoconversion can be considered in terms of four component processes, each with its own efficiency, namely light absorption (η_A), exciton diffusion and dissociation (η_D), charge transfer (CT) state separation (η_{CS}), and free carrier collection (η_{FC}). As such, with knowledge of η_{CS} and η_{FC} , coupled with an optical transfer matrix model for η_A , η_D and L_D can be extracted by fitting with a diffusion equation. In practice, the values of η_{CS} and η_{FC} are not known, and frequently taken as unity or assumed to be fixed with changes in device architecture^{39,42–45}. Thus, the extracted value of L_D is a lower bound to the actual, materials-specific L_D . This limitation, coming from unknown geminate and non-geminate recombination losses, must be overcome in order to extract intrinsic, materials-specific values of L_D .

Recently, we reported a technique based on transient photovoltage to overcome the non-geminate recombination limitation on extracting L_D from OPVs^{46,47}. Photovoltage can be quantitatively translated into the number of free carriers stored within the device. For timescales much shorter than the carrier lifetime, the free carrier generation rate can be extracted from the initial photovoltage rise induced by illumination. The previously unknown η_{FC} , therefore, can be quantitatively measured by comparing the results of photovoltage and photocurrent measurements. Interestingly, η_{FC} is found to be near-unity at short-circuit for many PHJ systems. Consequently, an inability to quantify geminate recombination loss is the primary factor frustrating accurate extraction of L_D in devices.

Despite the presence of unknown recombination losses, it is possible to measure the intrinsic L_D from a device without the need to assume a value for η_{CS} . Previously, Vandewal et al. have shown that relaxed interfacial CT states (lowest energy) are the dominant source for free carrier generation in a wide range of D–A systems⁴⁸. This conclusion is further confirmed by recent work by Kurpiers et al.⁴⁹. The value of η_{CS} is thus independent of whether a carrier originates from the donor or acceptor exciton. As such, a ratio of the donor and acceptor internal quantum efficiencies (η_{IQE}) cancels this unknown quantity and depends only on the exciton harvesting efficiencies (η_D) at short-circuit:

$$\frac{\eta_{IQE}^D}{\eta_{IQE}^A} = \frac{\eta_D^D \eta_{CS}}{\eta_D^A \eta_{CS}} = \frac{\eta_D^D}{\eta_D^A} \quad (1)$$

In order to model η_D , exciton diffusion is treated with a one-dimensional steady-state diffusion equation:

$$0 = D \frac{\partial^2 n(x)}{\partial x^2} - \frac{n(x)D}{L_D^2} + G(x) - n(x)k_F \text{ with } L_D = \sqrt{D\tau} \quad (2)$$

where n is the exciton density, D is the diffusion coefficient, τ is the exciton lifetime, and G is the optical exciton generation rate calculated by transfer matrix modeling. For systems with a spectral overlap of donor emission and acceptor absorption, the rate of donor–acceptor Förster energy transfer (rate constant: k_F) must be included. From the steady-state exciton density profile $n(x)$, the η_D can be determined as:

$$\eta_D = 1 - \frac{\int n(x)/\tau dx}{\int G(x)dx} \quad (3)$$

By fitting the η_D ratio in eq. (1) as a function of active layer thickness, L_D values for the donor and acceptor materials can be extracted simultaneously.

In this work, we apply the photocurrent-ratio method to extract L_D for both luminescent and dark organic semiconductors, including both small molecule and polymer active materials. We further demonstrate the broad utility of this approach by also extracting L_D for thin films of colloidal, inorganic semiconductor quantum dots. In order to compare the results of the photocurrent-ratio method to well-established photoluminescence quenching methods, we first consider the archetypical donor–acceptor pairing of boron subphthalocyanine chloride (SubPc) and C₆₀ (Fig. 1a), where both active materials are luminescent. This system shows negligible non-geminate recombination loss at short-circuit^{50,51}, and prior work suggests that free carriers are likely generated from a single relaxed CT state⁵², allowing eq. (1) to be applied. It is worth noting that in devices limited by non-geminate recombination, η_{FC} can be measured using transient photovoltage, leading to a modified, but equally useful form of eq. (1). For this luminescent pairing, we demonstrate that the values of L_D extracted using our device-based method are in excellent agreement with those extracted using conventional PL-based measurements. Importantly, we further show that our device-based method yields the intrinsic material L_D even for devices that suffer from very low efficiency.

Results

Extracting L_D from a ratio of internal quantum efficiencies. To accurately measure L_D in bilayer OPVs, it is important to ensure that the only mechanism for exciton dissociation is at the donor–acceptor interface. Quenching at other interfaces or via bulk-ionization will lead to errors in the extracted L_D . Figure 1b shows the SubPc–C₆₀ PHJ OPV used for the measurement of L_D . The wide energy gap organic semiconductors 1,3-bis(carbazol-9-yl)benzene (mCP) and bathocuproine (BCP) are employed as exciton blocking layers (EBLs) to prevent exciton quenching at

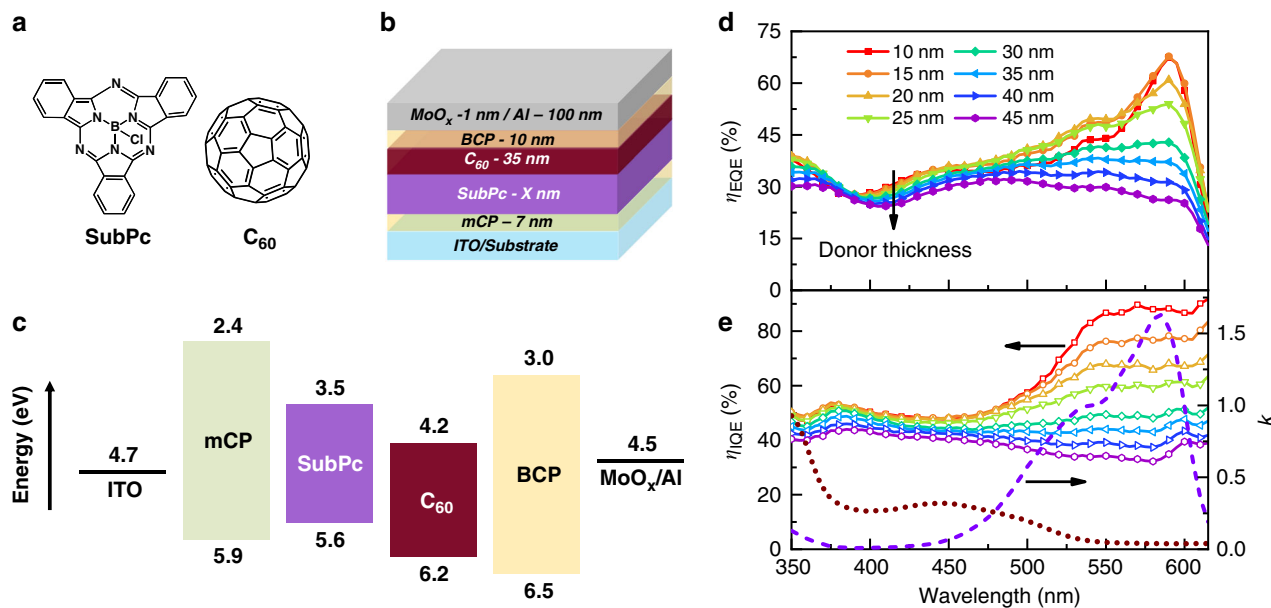


Fig. 1 Device architectures and quantum efficiency spectra for SubPc- C_{60} planar OPVs. **a** Molecular structure of SubPc and C_{60} . **b** Device architecture for SubPc- C_{60} planar OPVs. The SubPc thickness X varies from 10 nm to 45 nm. **c** Energy-level diagram for the devices in **b**. **d** The η_{EQE} spectra measured at short-circuit as a function of SubPc layer thickness. **e** The η_{IQE} spectra calculated by dividing the η_{EQE} spectra in **d** by the η_A calculated using a transfer matrix model. The extinction coefficients (k) of SubPc (purple dash line) and C_{60} (brown dot line) are also shown

active layer-electrode interfaces. The exclusion of quenching at the electrodes is critical for accurate measurements of L_D as exciton loss is observed when SubPc is in direct contact with ITO or the commonly used buffer layer MoO_x (Supplementary Figure 1)⁵³. A 1-nm-thick layer of MoO_x is used to increase the cathode work function and reduce the built-in electric field (E_{bi}) to exclude efficient exciton bulk-ionization processes at short-circuit⁵⁴. This is especially important for the SubPc- C_{60} system since both materials have been observed to show efficient free carrier generation in Schottky OPVs^{55,56}. While the application of a forward bias can also be used to reduce E_{bi} , the resulting carrier injection into the device could lead to exciton quenching, and an underestimate of L_D . It is worth noting that while a reduced E_{bi} could hinder the separation of relaxed CT states at the donor-acceptor interface, we will demonstrate that this does not impact our measurement provided η_{CS} is identical for charges originating from both active materials.

Figure 1d shows external quantum efficiency (η_{EQE}) spectra for SubPc- C_{60} PHJ devices as a function of SubPc donor-layer thickness with the acceptor and buffer layer thicknesses held fixed. The η_A of the active materials calculated using a transfer matrix formalism (Supplementary Figure 2) allows the η_{EQE} spectra to be converted to η_{IQE} spectra (Fig. 1e)⁴¹. To ensure the accuracy of the simulated η_A , the result from transfer matrix modeling is checked against experimentally determined device reflectivity (through the anode, reflecting off the cathode) measured at an incident angle of 15° to the substrate normal. The simulated 1-reflectivity (R) spectra (absorption of the device stack) agree well with experimental results as a function of donor thickness (Supplementary Figure 3). For the device with a donor thickness of 10 nm, the maximum η_{EQE} (at $\lambda = 590$ nm, SubPc absorption) exceeds 65% and the corresponding η_{IQE} is about 85%. This indicates that both exciton harvesting and charge collection are efficient in this device despite the reduced E_{bi} . From the extinction coefficients (k) of SubPc and C_{60} , spectral regions of dominant absorption for both donor and acceptor can be isolated. Accordingly, for the construction of the η_{IQE} ratio, the

individual η_{IQE} of the donor and acceptor are extracted from $\lambda = 575$ nm (primarily SubPc absorption) and $\lambda = 400$ nm (primarily C_{60} absorption), respectively. Consistent with eq. (1), a η_D ratio ($\lambda = 575$ nm to $\lambda = 400$ nm) is calculated as a function of SubPc thickness (Fig. 2a), which will be fit for L_D .

By fitting the η_D ratios in Fig. 2a, we simultaneously extract L_D values for SubPc and C_{60} of $L_D = (16.7 \pm 1.7)$ nm and $L_D = (18.5 \pm 1.9)$ nm, respectively. Due to the spectral overlap of SubPc PL emission and C_{60} absorption, donor-acceptor Förster energy transfer is included when using eq. (2). We have previously measured the SubPc- C_{60} Förster radius (R_0) to be 2.1 nm, consistent with the value of 2.1 nm calculated using Förster theory³². This value is short compared to the intrinsic L_D of SubPc, and hence does not significantly impact our measurement of L_D as diffusion is the dominant mechanism for harvesting in SubPc. As only the donor thickness is varied, the L_D of the donor and acceptor have different roles in determining the overall behavior of the η_D ratio as thickness changes (dash lines in Fig. 2a). For example, if the SubPc L_D is varied by 10% (C_{60} L_D fixed), the resulting η_D ratios converge at small thickness while diverging at larger thickness, varying the shape of the dependence on thickness. Similar changes in the C_{60} L_D (10%, SubPc L_D fixed) lead only to changes in the magnitude of the η_D ratio leaving the shape unchanged. To show this more explicitly, the values of η_D at $\lambda = 575$ nm and 400 nm are plotted as a function of donor thickness in Fig. 2b.

The observation of a constant acceptor η_D with increasing donor thickness offers some inherent advantages. First, the L_D of the donor and acceptor can be fit independently, as the shape of the η_D ratio (or normalized η_D ratio) only depends on donor L_D . As such, any non-ideality in acceptor L_D measurement, such as exciton loss at the acceptor-cathode interface, would not reduce the accuracy of donor L_D provided free carriers are still only generated at the D-A interface. In addition, the relative change in η_{CS} with donor thickness is directly reflected by the acceptor η_{IQE} . Accordingly, the decrease in η_{IQE} (400 nm) with SubPc thickness (Fig. 1e) indicates that a thicker donor layer leads to a lower η_{CS} .

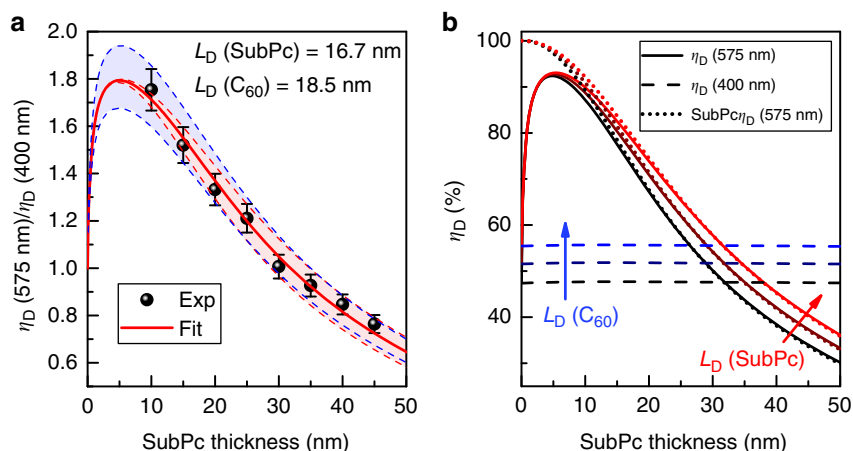


Fig. 2 Extracting L_D from the thickness dependence of the diffusion efficiency ratio. **a** Diffusion efficiency ratio ($\lambda = 575$ nm to $\lambda = 400$ nm) as a function of SubPc layer thickness with the corresponding exciton diffusion length (L_D) extracted from the fit (solid red line) to the data. Red (blue) dash lines are simulated diffusion efficiency ratio curves for a 10% change in extracted SubPc or C_{60} L_D while keeping the counterpart L_D fixed. Error bars of diffusion efficiency ratio were determined based on the standard deviation of measured devices. **b** Solid lines are the diffusion efficiency at $\lambda = 575$ nm as a function of SubPc layer thickness for different SubPc L_D ($= 15.0/16.7/18.3$ nm) and fixed C_{60} $L_D = 18.5$ nm. Similarly, the horizontal dash lines are the diffusion efficiency at $\lambda = 400$ nm for different C_{60} L_D ($= 16.7/18.5/20.3$ nm) and fixed SubPc $L_D = 16.7$ nm. The diffusion efficiencies of SubPc at $\lambda = 575$ nm are also plotted as dot lines

This is likely due to an increase in bulk resistance of the donor layer that consumes more built-in voltage and thus reduces the electric field strength at D–A interface⁵⁷.

Photoluminescence-based L_D measurements. To determine whether the L_D extracted from the η_{IQE} ratio is intrinsic, conventional PL-based measurements are carried out for both SubPc and C_{60} . In many previous studies, η_{EQE} -based measurements of L_D have not been in agreement with those extracted from PL due to geminate recombination losses^{46,50}, which are in general not negligible. If the recombination limitations are fully overcome in the method described here, these measurements should yield the same L_D . For luminescent SubPc, the intrinsic L_D is extracted using thickness-dependent PL quenching and compared to the result obtained using the photocurrent-ratio method. In order to make a proper comparison, PL-quenching measurements are carried out on the identical device architecture used to measure L_D via η_{IQE} (Fig. 3a). Light having a wavelength of $\lambda = 500$ nm is incident through the ITO anode at an angle θ of 70° . As the emitted photons represent the excitons that fail to reach D–A interface, the PL intensity can be expressed as:

$$PL = \eta_A(1 - \eta_D)(I_{in}\eta_{PL}\eta_{det}) \quad (4)$$

where I_{in} is the incident photon flux, η_{PL} is the photoluminescence efficiency, η_{det} is the detection efficiency for all the emitted photons. Typically, L_D is extracted by fitting a ratio of the integrated PL of a quenched sample (Q) and an unquenched sample (UQ). This PL ratio reflects the number of recombining excitons (i.e., not collected at the quenching interface) under steady-state:

$$\frac{PL^Q}{PL^{UQ}} = \frac{\eta_A^Q(1 - \eta_D^Q)(I_{in}\eta_{PL}\eta_{det})}{\eta_A^{UQ}(I_{in}\eta_{PL}\eta_{det})} = \frac{\eta_A^Q(1 - \eta_D^Q)}{\eta_A^{UQ}} \quad (5)$$

The η_A and η_D can be simulated using a transfer matrix formalism and a diffusion model as previously described. Here, the SubPc- C_{60} PHJ devices in Fig. 1b are used as quenched samples, with C_{60} acting as the quencher. A set of unquenched samples ($\eta_D = 0$) are fabricated by replacing acceptor C_{60} with the exciton blocking material BCP. The resulting PL ratio is plotted in Fig. 3b and fit as a function of SubPc thickness, yielding a SubPc L_D of

(16.6 ± 2.0) nm. Clearly, the photocurrent-ratio and PL-based measurements conducted on the same set of devices show excellent agreement for the extracted L_D . This agreement suggests that the charge recombination present in the device-based measurement does not limit our ability to extract L_D .

To further verify the extracted value of L_D , we use the L_D determined by the PL ratio to simulate the PL of quenched devices with eq. (4). Figure 3c shows the integrated device PL of SubPc- C_{60} PHJ devices as a function of SubPc thickness. Taking the prefactor ($I_{in}\eta_{PL}\eta_{det}$) as independent of SubPc thickness, the experimental results are in good agreement with the simulation using $L_D = 16.6$ nm for SubPc.

In most reports of PL-based measurements of L_D , actual device architectures are not utilized, replaced instead with simple film stacks. In this configuration, exciton dissociation due to bulk-ionization is negligible due to the absence of electrodes. If bulk-ionization in SubPc is negligible for the devices in Fig. 1b, L_D values for SubPc extracted from device and thin-film PL should agree. As shown in Fig. 3d, SubPc thin films are deposited on a 10-nm-thick mCP/glass substrate to ensure the SubPc film morphology is similar to the device-based measurement. The quenched films are capped with a 10-nm-thick layer of 1,4,5,8,9,11-hexaazatriphenylene hexacarbonitrile (HATCN) while the unquenched films are capped with a 10-nm-thick layer of mCP⁵⁸. Based on the thickness-dependent PL ratio of Fig. 3e, an intrinsic L_D of (16.9 ± 2.0) nm is determined for SubPc. This value is larger than previous reports of the SubPc L_D , which is around 10 nm^{32,59,60}. However, previous studies typically deposit SubPc directly on an inorganic substrate such as glass as opposed to a wide energy gap organic buffer layer. By removing the 10-nm-thick mCP layer beneath the SubPc for unquenched samples, we observe a reduction in η_{PL} , suggesting a difference in the morphology of SubPc on different substrates.

For weakly luminescent C_{60} , a thin layer can result in a very low signal to noise ratio, which increases error for the extraction of L_D . As such, we employ a 50-nm-thick C_{60} layer and use spectrally resolved (SPR) PL quenching instead of thickness-dependent PL quenching⁵⁹. We also use quartz as the substrate to further reduce the background noise. Figure 3f shows PL excitation spectra for the quenched and unquenched C_{60} films at an emission wavelength of $\lambda = 750$ nm. The PL ratio is fit as a

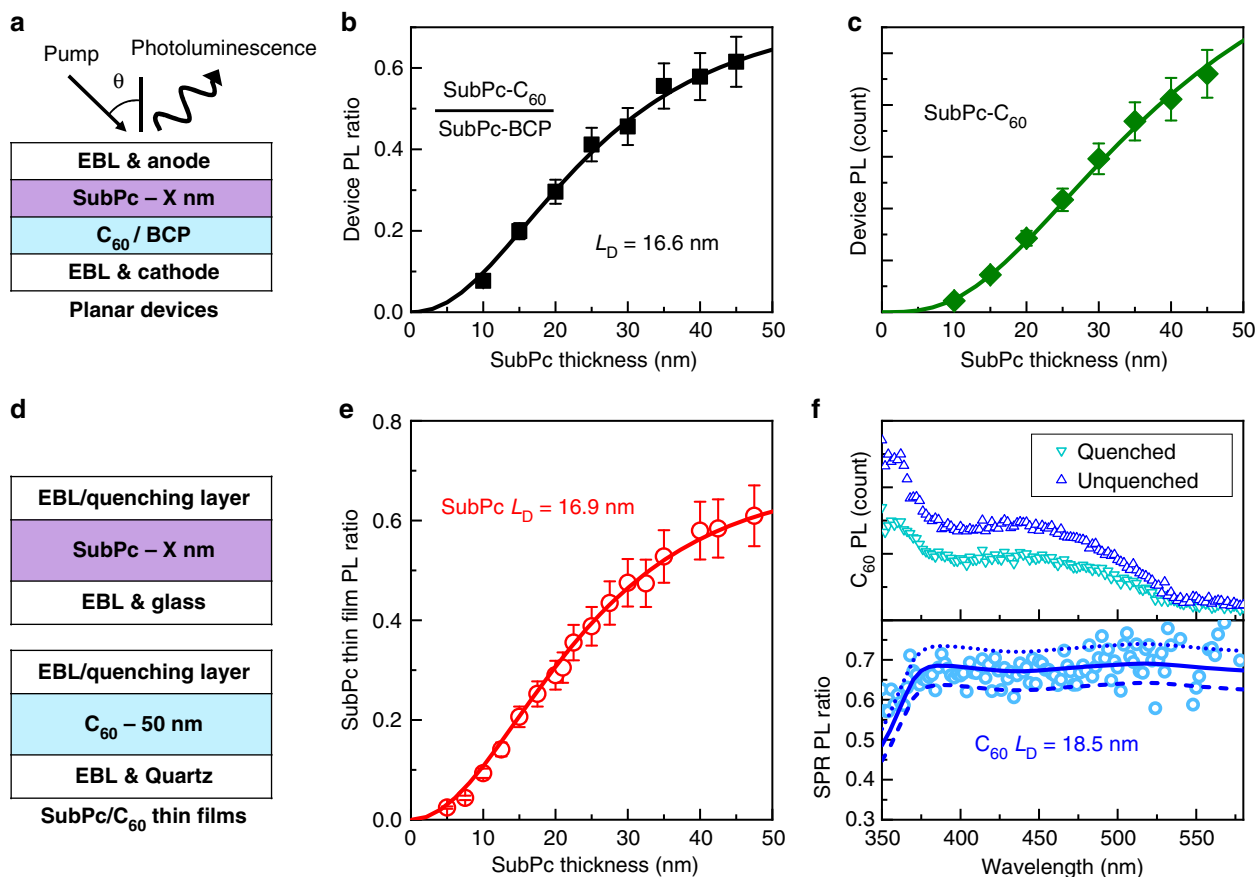


Fig. 3 Photoluminescence-based measurements of exciton diffusion length. **a** OPVs used for the extraction of L_D via photoluminescence (PL) quenching having the structure: ITO/7 nm mCP/X (=10–45) nm SubPc/35 nm C_{60} (quenched) or BCP (unquenched)/10 nm BCP/1 nm MoO_x /100 nm Al. The quenched samples are the same set of devices used for internal quantum efficiency measurements. **b** PL ratio defined in eq. (5) versus SubPc thickness. **c** SubPc PL intensity of the quenched samples versus SubPc thickness. The solid line is fit of the data using eq. (4). Error bars reflect the run-to-run variation in PL intensity (standard deviation). **d** Architectures for conventional thin-film PL ratio L_D measurements of SubPc and C_{60} . SubPc architectures have the structure: glass/10 nm mCP/X (=5.0–47.5) nm SubPc/10 nm HATCN (quenched) or mCP (unquenched) while C_{60} architectures have the structure: quartz/10 nm BCP/50 nm C_{60} /10 nm HATCN (quenched) or BCP (unquenched). **e** The PL ratio of SubPc films as a function of SubPc thickness. **f** Excitation spectra (upper panel) for the quenched and unquenched C_{60} films at an emission wavelength of 750 nm. The resulting spectrally resolved (SPR) PL ratio versus pump wavelength is shown in lower panel. SubPc films and devices are all pumped with $\lambda = 500$ nm light. The incident angle is 70° for all incident light. Error bars for PL ratios are propagated from measured spectra and are proportional to the standard deviation in PL intensity measured multiple times

function of incident excitation wavelength, yielding an intrinsic L_D of (18.5 ± 3.0) nm for C_{60} . The excellent consistency of results between thin-film and device-based measurements further confirm that an intrinsic L_D can be accurately measured using the η_{IQE} -based approach reported here. This agreement also suggests that there are no other diffusive dark states in SubPc and C_{60} that contribute to photocurrent since the photocurrent-ratio measurement probes both dark and emissive excitons while the PL-based measurement is only sensitive to emissive states.

Relaxation losses for high-energy excited states. With the L_D of SubPc and C_{60} extracted from device photocurrent spectra shown to be intrinsic, materials-relevant quantities, these values can be used to accurately simulate exciton diffusion and recombination losses in OPVs. The unknown geminate recombination loss (η_{CS}) that was circumvented in eq. (1) by taking a ratio of η_{IQE} values can now be calculated as the ratio of η_{IQE} to the calculated η_D . Figure 4a shows the simulated η_{EQE} spectra for SubPc- C_{60} PHJ devices using the L_D extracted in Fig. 1b, and the extracted η_{CS} . The simulated η_{EQE} spectra agree well with experimental results except for the wavelength range of $\lambda = 410$ –550 nm. The observed

η_{EQE} overestimation indicates the presence of a photocurrent loss pathway prior to exciton diffusion, or stated differently, the exciton relaxation yield is not unity. It is also worth noting the clear reduction in η_{CS} with increasing donor layer thickness, likely reflecting a reduction in E_{bi} .

To identify whether the exciton relaxation loss is from SubPc or C_{60} , a second donor-acceptor system of SubPc-NPD is examined where SubPc serves as the electron acceptor (or hole donor)⁷. To ensure that the SubPc morphology is unchanged, an inverted device architecture is employed (ITO/7 nm mCP/X nm SubPc/35 nm NPD/10 nm mCP/3 nm MoO_x /100 nm Al) so that SubPc is still deposited on mCP. In these devices, the electron acceptor SubPc has low electron mobility, which can lead to significant recombination losses due to slow CT state separation⁶¹. As shown in Supplementary Figure 4, the SubPc η_{IQE} (from $\lambda = 525$ nm) and NPD η_{IQE} (from $\lambda = 385$ nm) are both very low (less than 8%). By fitting the η_D ratio as a function of SubPc thickness, an L_D of (15.2 ± 2.0) nm is obtained for SubPc, close to the value extracted from the SubPc- C_{60} system despite significantly increased recombination losses. This result illustrates the power of the photocurrent-ratio technique, even in a low-efficiency device with substantial recombination loss, the correct,

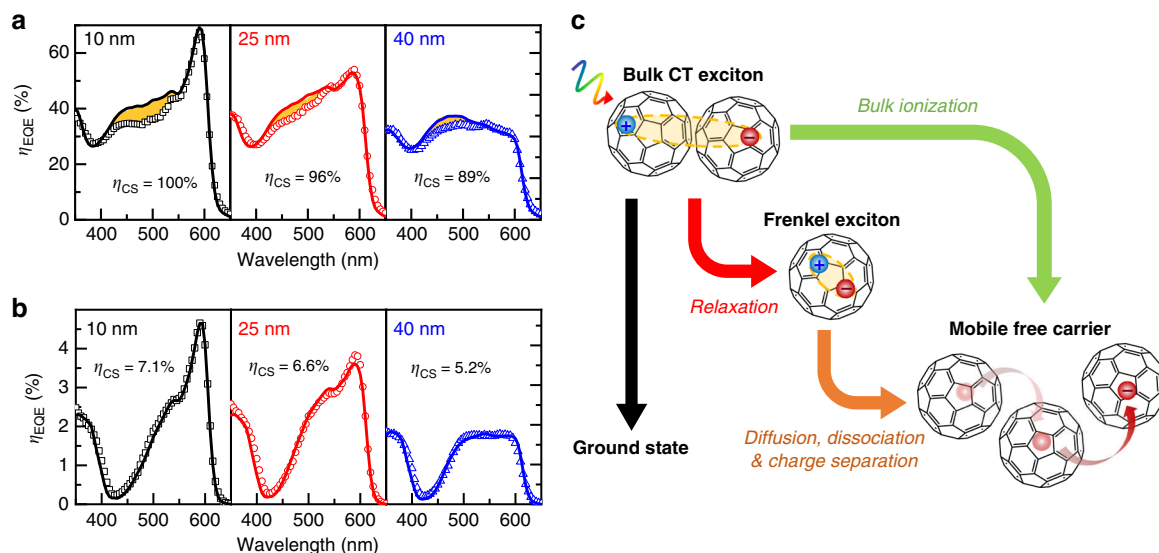


Fig. 4 Simulation of external quantum efficiency for extraction of recombination loss. **a** External quantum efficiency spectra for SubPc- C_{60} planar OPVs as a function of SubPc thickness (10, 25, and 40 nm). Experimental results are shown in symbols while solid lines are simulated spectra. **b** The experimental (symbols) and simulated (solid lines) external quantum efficiency spectra of SubPc-NPD planar OPVs versus SubPc thickness. **c** Schematic of free carrier generation in C_{60} from a photoexcited bulk CT exciton. The bulk CT excitons absorb over the wavelength range of $\lambda = 410$ to 550 nm, while the low energy Frenkel excitons correspond to absorption at λ greater than 550 nm

intrinsic value of L_D is extracted. For the NPD dominant absorption region, an η_D (385 nm) = 47.1% is determined. Due to the large spectral overlap between NPD fluorescence and SubPc absorption, the dominant exciton harvesting mechanism within the NPD layer is Förster energy transfer to SubPc instead of exciton diffusion. In order to extract the L_D of NPD, a partner material should be chosen with reduced spectral overlap. Figure 4b shows the simulated η_{EQE} spectra for SubPc-NPD PHJ devices based on the parameters extracted. Unlike the SubPc- C_{60} case, simulated and experimental η_{EQE} spectra show broadband agreement as a function of SubPc thickness. This suggests that the exciton relaxation losses in SubPc- C_{60} devices originate only from excited states in C_{60} .

Interestingly, the region ($\lambda = 410$ –550 nm) where exciton relaxation losses are observed is consistent with the broad absorption peak of C_{60} bulk CT excitons⁶². These bulk CT excitons can be photoexcited directly and their absorption (λ_{peak} around 450 nm) has been observed to decrease drastically when diluting C_{60} in thin-film or solution^{13,63}. This spectral agreement indicates that high energy bulk CT excitons do not uniformly relax to lowest energy Frenkel excitons in C_{60} despite their reasonably large energy difference (about 0.5 eV). For the C_{60} bulk CT excitons that fail to relax, they may still contribute to photocurrent through bulk-ionization (Fig. 4c), especially in devices with high built-in fields (see additional discussion in Supplementary Figure 5, Note 1). As such, both relaxation loss and bulk-ionization of bulk CT excitons must be considered in order to accurately simulate broadband η_{EQE} spectra of C_{60} -based planar OPVs.

Elucidating exciton quenching and dissociation pathways. In order to accurately probe intrinsic exciton diffusion in OPVs, the architecture of Fig. 1b was carefully designed to prevent exciton dissociation anywhere but at the D–A interface. As such, comparing its behavior to that of a conventional OPV allows additional exciton dissociation via electrode-organic interfaces and the built-in electric field to be quantified. For instance, removal of mCP between ITO and SubPc (10 nm) leads to a reduction in the SubPc exciton harvesting efficiency, permitting a quantification of

quenching at the ITO interface. By inserting a wide gap interlayer to frustrate dissociation at the D–A interface, the photocurrent contribution from bulk-ionization is also quantified. Combining these results with an exciton diffusion model and importantly, accurate measurements of L_D , the fraction of photogenerated excitons consumed by various quenching, dissociation, and recombination pathways can be determined, as shown in Supplementary Figure 6. For $\lambda = 590$ nm (mainly SubPc), the fraction of excitons dissociated at the D–A interface, quenched at the ITO-SubPc interface, and undergoing recombination within the donor layer are 73%, 21%, and 6%, respectively. For $\lambda = 450$ nm (mainly C_{60}), 88% of C_{60} excitons relax to the lowest energy Frenkel states (47% dissociated at D–A interface and 41% recombining in the acceptor layer). Among the remaining 12% bulk CT excitons, 4% can contribute to photocurrent through bulk-ionization and 8% recombine prior to relaxation. These results suggest an important role for bulk-ionization via the built-in-field (especially for bulk CT excitons) in fullerene-based devices. This quantitative decoupling of photoconversion would not be accessible without the device-based L_D measurement reported here.

Dark small molecules and other excitonic materials. With the photocurrent-ratio method thoroughly vetted against conventional PL approaches for SubPc- C_{60} , we investigate exciton transport in two dark small molecule materials, boron sub-naphthalocyanine chloride (SubNc) and C_{70} (Fig. 5a). While these materials have been frequently utilized in high-efficiency OPVs, their intrinsic L_D has not been directly measured as they are inaccessible by PL-based techniques^{7,12,58,64}. Similar to the SubPc- C_{60} system, we employ a SubNc- C_{70} PHJ device with varying donor thickness to extract the intrinsic L_D of both dark materials (structure: ITO/8.5 nm mCP/X (= 9–40.5) nm SubNc/27 nm C_{70} /11 nm BCP/1 nm MoO_x /100 nm Al). Based on the extinction coefficients (k) of SubNc and C_{70} shown in Fig. 5b, the individual η_{IQE} of the donor and acceptor can be extracted from $\lambda = 685$ nm (SubNc absorption peak) and $\lambda = 430$ nm (primarily C_{70} absorption), respectively. By fitting the donor–acceptor η_D ratio (determined as previously described) as a function of SubNc

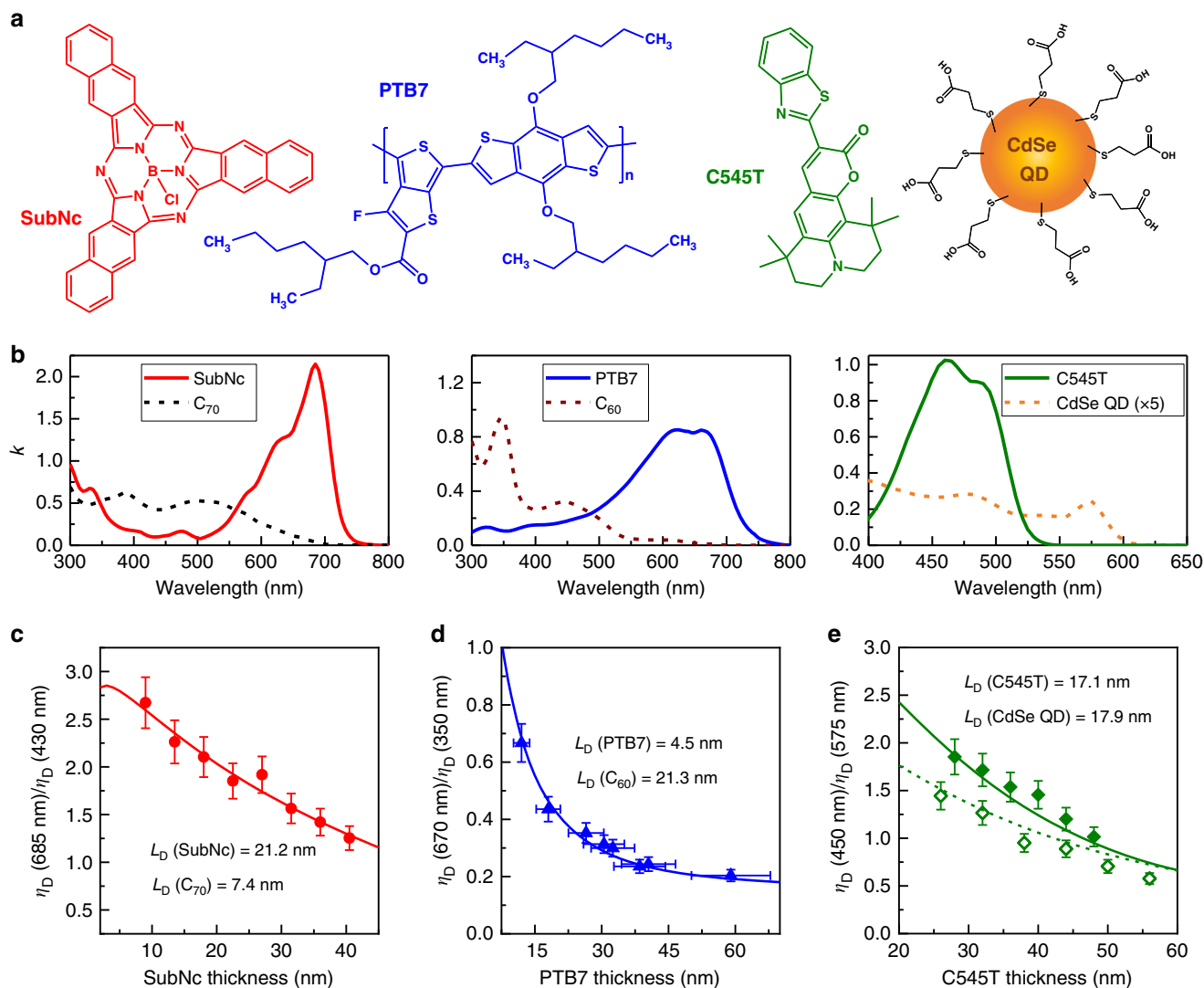


Fig. 5 Measuring L_D of dark small molecules, polymers, and quantum dots. **a** Molecular structure of SubNc, PTB7, C545T and schematic of a CdSe quantum dot (QD) with 3-MPA ligands on the surface. **b** The extinction coefficients (k) of SubNc, C_{70} , PTB7, C_{60} , C545T, and CdSe QD thin films. The k of QDs is shown with a 5-fold magnification. **c** Diffusion efficiency ratio ($\lambda = 685\text{ nm}$ to $\lambda = 430\text{ nm}$) as a function of SubNc layer thickness with the corresponding exciton diffusion length (L_D) extracted from the fit (solid line) to the data. **d** Diffusion efficiency ratio ($\lambda = 670\text{ nm}$ to $\lambda = 350\text{ nm}$) as a function of PTB7 layer thickness and CdSe QD thickness (solid symbols: 66 nm QD layer; open symbols: 42 nm QD layer). The L_D values are extracted by fitting both sets of data simultaneously (solid line: fit for 66 nm QD devices; dash line: fit for 42 nm QD devices). Error bars of diffusion efficiency ratio represent run-to-run variation (standard deviation) for the devices tested. Error bars of PTB7 thickness were standard deviation of multiple polymer thin films fabricated with the same procedures

thickness (Fig. 5c), we simultaneously extract an L_D of (21.2 ± 2.2) nm for SubNc and an L_D of (7.4 ± 0.8) nm for C_{70} (see Supplementary Figure 7 for η_{EQE} , η_A and η_{IQE} spectra). The longer L_D of SubNc compared to SubPc ($L_D = 16.7\text{ nm}$) is consistent with previous observations based on the PL of dilute solid solutions⁵⁸. The extracted L_D for C_{70} is significantly smaller than that of C_{60} ($L_D = 18.5\text{ nm}$). To better understand this difference, further work is needed to investigate differences in exciton lifetime and spin state between these fullerenes. Unlike the SubPc- C_{60} case, the simulated broadband η_{EQE} spectra of SubNc- C_{70} OPVs agree well with the experimental results, suggesting negligible exciton relaxation loss in C_{70} . This result may reflect a reduced CT state character for excitons in C_{70} .

To demonstrate the applicability of the photocurrent-ratio method in other excitonic systems, we also show two examples measuring exciton transport in solution processed PTB7 polymer films and inorganic CdSe quantum dot (QD) films. PTB7 is a

high-performing polymer electron donor in OPVs, with demonstrated power efficiencies as high as 9.2% when combined with the fullerene acceptor PC₇₁BM⁶⁵. Here, we employ it as an electron-donor material paired with fullerene acceptor C_{60} . Figure 5d shows the PTB7- C_{60} η_D ratio as a function of PTB7 thickness obtained from planar OPVs with a structure: ITO/2.5 nm HfO_2 /X ($= 12\text{--}59$) nm PTB7/37 nm C_{60} /10 nm BCP/1 nm MoO_x /100 nm Al (see Supplementary Figure 8 for η_{EQE} , η_A and η_{IQE} spectra). A thin layer of wide energy gap HfO_2 is utilized as an exciton blocking layer at ITO/donor interface (deposited via atomic layer deposition). The donor η_{IQE} is extracted from $\lambda = 670\text{ nm}$ (PTB7 absorption peak) while the acceptor η_{IQE} is extracted from $\lambda = 350\text{ nm}$ (C_{60} Frenkel exciton absorption peak). As negligible exciton relaxation loss is observed at $\lambda = 350\text{ nm}$ in the previous SubPc- C_{60} case (Fig. 4a), it is assumed that C_{60} has 100% exciton relaxation yield at this wavelength. Fitting the η_D ratio in Fig. 5d yields a short L_D of (4.5 ± 0.5) nm

for PTB7 and an L_D of (21.3 ± 2.2) nm for C_{60} . The C_{60} L_D is similar to the value extracted from the SubPc- C_{60} system (18.5 nm).

For CdSe QD thin films, the QDs are zincblende nanocrystals (size ~ 4 nm) stabilized with 3-mercaptopropionic acid (3-MPA) after treatment via solid-state ligand exchange⁶⁶. The resulting thin films have a very low extinction coefficient ($k = 0.05$ at excitonic peak, $\lambda = 575$ nm), and are therefore paired with a wider energy gap small molecule 2,3,6,7-tetrahydro-1,1,7,7-tetramethyl-1H,5H,11H-10-(2-benzothiazolyl)quinolizino[9,9a,1gh]coumarin (C545T), which does not absorb at $\lambda = 575$ nm. Wide gap materials HfO_2 and di-[4-(N,N-di-p-tolyl-amino)-phenyl]cyclohexane (TAPC) are utilized as exciton blocking layers for CdSe QDs and C545T, respectively. The CdSe QD-C545T planar cell has an inverted device architecture: ITO/2.5 nm HfO_2 /X ($= 42, 66$) nm CdSe QD/Y ($= 26-56$) nm C545T/11 nm TAPC/10 nm MoO_3 /100 nm Al, where the CdSe QDs serves as the electron acceptor layer and photogenerated electrons are collected at ITO. It is again worth noting the ability of the photocurrent-ratio method in yielding intrinsic values of L_D even in devices with low efficiency. This allows active materials to be selected solely on the basis of realizing a minimal overlap in optical absorption. The QD film thickness is controlled by the number of cycles for the ligand exchange process⁶⁶. Figure 5e shows the C545T-CdSe QD η_D ratio as a function of C545T thickness for two different QD film thicknesses (see Supplementary Figure 9 for broadband η_{EQE} , η_A and η_{IQE} spectra). The donor η_{IQE} is extracted at $\lambda = 450$ nm (C545T absorption peak) while the acceptor η_{IQE} is extracted at $\lambda = 575$ nm (QD excitonic absorption peak). Results for devices with QD layer thickness of 42 nm and 66 nm are fitted simultaneously, yielding an L_D of (17.9 ± 3.6) nm for the CdSe QDs and an L_D of (17.1 ± 3.4) nm for C545T. It is worth noting that the L_D of C545T extracted here is consistent with separate PL-based measurements we have carried out (16.7 nm). If instead the η_D ratio is fit for each QD thickness, the 42 nm (66 nm) QD-C545T devices yield an L_D of 18.7 nm (15.5 nm) and 19.8 nm (16.8 nm) for the QDs and C545T, respectively. The L_D of CdSe QDs extracted here is smaller than that previously reported for CdSe core-shell counterparts (20 to 40 nm)^{67,68}, likely reflecting that a wide gap shell is critical to frustrate exciton decay and enhance exciton transport for CdSe QDs.

Discussion

We demonstrate a simple photocurrent-ratio method to measure the intrinsic L_D of excitonic semiconductors in bilayer photovoltaic cells. The impact of often unknown recombination losses is negated when taking a ratio of donor and acceptor η_{IQE} . For the luminescent organic pairing SubPc and C_{60} , their L_D extracted using this method are in excellent agreement with those extracted from conventional PL-quenching measurements, a direct result of the ability to remove the role of unknown geminate recombination losses. With knowledge of the intrinsic values of L_D , we are able to investigate the potential for relaxation losses, which are typically overlooked in device-based studies of L_D . Indeed, bulk CT excitons generated in C_{60} have non-unity relaxation yield to Frenkel states and can generate free carriers directly through bulk-ionization. The generality of this photocurrent-ratio method is further demonstrated by extracting L_D for the dark small molecule SubNc, C_{70} , the high-performance polymer PTB7, as well as for CdSe quantum dot thin films. Thus, we demonstrate a straightforward measurement for the extraction of L_D that is equally applicable to both luminescent and dark excitonic materials capable of being integrated into a bilayer photovoltaic cell.

Methods

Chemicals. For this study, SubPc (99%), mCP (99%), TPBi (99%), C545T (99%), TAPC (99%), and PTB7 (Mw > 50,000) were obtained from Lumtec Inc., C_{60} (99%) and C_{70} (99%) were obtained from MER Corporation, MoO_3 (99%) and BCP (98%) were obtained from Alfa Aesar, chloroform (99%), 3-mercaptopropionic acid (99%), octane (98%), oleic acid (tech. grade 90%) acetonitrile (99.5%), and methyl acetate (anhydrous) were obtained from Sigma-Aldrich, selenium dioxide (99.8%) and 1-octadecene (90%) were obtained from Acros Organics. All materials above were used as received. The NPD (99%) was synthesized by the Dow Chemical Company and purified once by temperature-gradient sublimation⁶⁹. Cadmium myristate was prepared on a multi-gram scale according to the method reported by Chen et al.⁷⁰.

Synthesis of zincblende CdSe QDs. Zincblende CdSe QDs with oleic acid capping ligands were synthesized as previously reported⁶⁶, based off the original synthesis by Chen and et al.⁷⁰. Briefly, 1-octadecene (63 mL), cadmium myristate (570 mg) and selenium dioxide (110 mg) were added to a 3-neck round bottom flask and degassed at 75 °C for 1 h. After degassing, the reaction mixture was heated to 240 °C, at which point 1 mL of oleic acid was added dropwise to the solution once a red color was achieved. The reaction was allowed to proceed for 15 min and then cooled to room temperature for purification by centrifugation in methyl acetate. The resulting precipitate was dispersed in octane and filtered using a 0.2 μ m PTFE syringe filter prior to film fabrication. Resulting solution concentration was ~ 25 g L⁻¹.

Thin-film and device preparation. Organic photovoltaic cells were fabricated using indium-tin-oxide (ITO)-coated glass substrates with a sheet resistance of 8–12 Ω per \square . Substrates were cleaned in tergitol solution and in organic solvents and treated in UV-Ozone ambient for 10 min prior to thin-film deposition. All polymer and QD films were spin-coated onto an HfO_2 -coated ITO substrate. The HfO_2 was deposited via atomic layer deposition at 200 °C. The polymer PTB7 was first dispersed in chloroform and then spin-coated at 3000 rpm for 45 s. The obtained samples were annealed in N_2 at 140 °C for 10 min. The polymer film thickness was controlled via the concentration of the PTB7 solution (2–10 g L⁻¹). Spin-coating and buildup of QD film thickness were realized using a solid-state ligand exchange procedure. CdSe QDs dispersed in octane were spin-coated at 1200 rpm for 30 s and then 6000 rpm for 60 s. The latter process is found to improve film uniformity and reproducibility. Next, 3-MPA (1% v/v) in acetonitrile was first deposited onto the film and allowed to sit for 10 s to facilitate the ligand exchange. The sample was then spun again at 1200 rpm for 30 s. Finally, the film was rinsed with pure acetonitrile by spinning at 6000 rpm for 60 s. This process was repeated 3–4 times until the desired QD film thickness was achieved. All other layers were deposited at room temperature by high vacuum thermal evaporation at a pressure of less than 8×10^{-7} Torr. The active area of the obtained device is 0.785 mm², defined by the cathode area.

Optoelectronic characterization. Photoluminescence quenching data were recorded using a Photon Technology International QuantaMaster Fluorometer. All photoluminescence measurements were performed under N_2 purge. Photoluminescence quenching measurements were made at an incident angle of 70° to the substrate normal. External quantum efficiency measurements were collected by measuring the photocurrent under monochromatic light illumination using a 300 W Oriol Xe lamp, a monochromator, an optical chopper wheel, and an SR810 lock-in amplifier. Error bars for L_D represent a 95% confidence interval extracted from fitting parameters. All film thicknesses, reflectivity spectra were measured with a J. A. Woollam spectroscopic ellipsometer. The device reflectivity measurements were made at an incident angle of 15° to the substrate normal. Film thicknesses were fit using a Cauchy model. For simulations of device absorption efficiency optical constants of organic and QD thin films were extracted by fitting transmission (at normal incidence) and reflection (incident angle: 15°) simultaneously with a transfer matrix formalism (provided in Supplementary Figure 10).

Data availability

The data presented within this manuscript are available from the corresponding author upon reasonable request.

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Author contributions

T.Z. and R.J.H. conceived and initiated the study. T.Z. carried out the experiments and data analysis. D.B.D. synthesized the CdSe QDs and performed atomic layer deposition of HfO_2 . T.Z. and R.J.H. prepared the manuscript. T.Z., D.B.D., V.E.F. and R.J.H. contributed to the revision and evaluation of the manuscript.

Additional information

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